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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/039,867	QI, JIEMING	
Examiner	Art Unit	
Tan V. Mai	2193	

SEARCHED			
Class	Subclass	Date	Examiner
updated	search	4/27/2005	MAI
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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updated search NEW Data Bases Search (see attached copy)	4/27/2005	MAI	
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